Native Air-Formed Oxide Film and its Effect on Magnesium Alloys Corrosion

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Abstract: The present work uses X-ray photoelectron spectroscopy (XPS) analysis to compare the chemical composition of native oxide films formed spontaneously on commercial pure magnesium and AZ31, AZ80 and AZ91D magnesium alloys. The study considers both the outer surface and inner regions of the films with the assistance of argon ion bombardment. Possible relationships are established between the alloy Al content and the native oxide film characteristics. The Al content is very similar in the oxide films on all three studied alloys. XPS identifies a much greater film thickness on AZ80 and AZ91D specimens than on AZ31 and pure Mg specimens, which seems to be related with the presence of β phase (Mg17Al12) on the AZ91D alloy surface and of the eutectic α-Mg/β on the AZ80 alloy surface. Considerable Ca segregation is observed (directly related with the calcium impurities content in the bulk material) towards the outer surface of the metal, where it appears in the form of calcium oxide. Direct correspondence is found between the thickness of the native oxide film formed spontaneously on the surface of magnesium and its alloys and their subsequent corrosion resistance in exposure to a 3.5 wt% NaCl solution.

Keywords: Magnesium alloys, native oxide film intermetallics, impurities, XPS.

1. INTRODUCTION

The chosen study materials, Mg-Al alloys, have drawn great scientific and technical interest in the last two decades. From a practical viewpoint, magnesium is the lowest density structural metal, making it highly attractive for use in the automotive, aerospace, IT and electronics industries, and for the development of new biomaterials for orthopaedic and cardiovascular applications, where weight plays a decisive role. However, magnesium is one of the most chemically active metals and its corrosion resistance is a key point limiting its use in real service conditions.

Despite the large number of papers published on the corrosion mechanisms of Mg-Al alloys, certain aspects of these materials still remain to be fully clarified. Many researchers have carried out studies to establish relationships between the alloy microstructure (amount and distribution of β phase in alloys) or the Al content in the bulk alloy and its corrosion resistance [1-34]. Far fewer studies have addressed aspects related with the chemical composition of the thin native oxide films that form on the outer surface (thicknesses of the order of 3 nm) in contact with the atmosphere or with solutions of low aggressivity [35-46]. Differences in the thickness and chemical composition of these films, as a function of the alloy microstructure and alloying element composition, can yield basic information about their formation on Mg-Al alloys in the atmosphere or during immersion in saline solutions.

Many papers have reported impurity element segregation at or near the surface of magnesium and Mg alloys as a result of the casting process. Minor contaminant elements (Fe, Ni and Cu) precipitate as intermetallic phases when their solubility limit is exceeded. These intermetallic phases on the surface can act as galvanic cathodes and accelerate the alloy's corrosion process [1,2]. Nevertheless, although calcium is one of the commonest contaminants in many metals, no references have been found to superficial calcium enrichment on magnesium or Mg alloys as a consequence of the casting process. The greatest impediment to obtaining information on this phenomenon is that the segregation of Ca impurities (few ppm) towards the surface takes place in very thin layers (one monolayer), so thin that they are often inappreciable by conventional materials characterisation techniques (SEM/EDX or TEM) [47]. In this study the XPS technique has yielded highly promising results, since it allows the analysed thickness to be reduced to only 3 nm and provides information on the oxidation state of the detected element.

The present research has focused on four magnesium alloys selected to give specific and substantial differences in the surface chemistry of the oxide film formed after the casting process. As will be seen throughout the work, the behaviour of these alloys falls into two clearly differentiated groups: one formed by alloys AZ91D and AZ80, containing higher Al percentages; and the other formed by AZ31 and 99% pure Mg (Table 1). Each presents different possibilities regarding the segregation and oxidation tendencies of the alloying elements and the composition and distribution of intermetallic phase particles on the magnesium surface. The higher alloying element concentration in the AZ91D and AZ80 systems tends to promote the occurrence of second phase intermetallics on the surface and in the bulk.
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The objectives of this research are as follows:

1. To study the chemical composition of the native oxide film that forms spontaneously on the surface of magnesium and AZ31, AZ80 and AZ91D alloys in the process of their obtainment. It will be attempted to find relationships between the alloying element contents in the bulk material, the thickness of the native oxide film formed, and the amount of Al segregated to the outer surface.

2. To analyse the segregation of Ca impurities from the bulk material to the outer surface of the specimens as a result of the material obtainment process.

3. To find possible relationships between the thickness of the native oxide film and subsequent corrosion resistance in immersion tests in 3.5% NaCl.

2. EXPERIMENTAL PROCEDURE

2.1. Test Materials

The chemical compositions of the tested magnesium alloys (AZ31, AZ80 and AZ91D) are listed in Table 1. Pure Mg was used as the reference material. Mg and AZ31 were manufactured in wrought condition and supplied in plates of 3 mm thickness, whereas AZ80 and AZ91D alloys were manufactured by a casting process and were supplied in the form of billets of 300 and 250 mm in diameter, respectively. All the materials were supplied by Magnesium Elektron Ltd. The average surface roughness of the samples was <1 μm.

2.2. Preparation and Scanning Electron Microscopy (SEM) Characterisation

For their metallographic characterisation the specimens were wet ground through successive grades of silicon carbide abrasive papers from P120 to P2000 followed by finishing with 0.1 μm diamond paste. Two etching reagents were used: a) Nital, 5 mL HNO₃ + 95 mL ethanol for up to 15 s, to reveal the constituents and the general microstructure of pure Mg, AZ80, and AZ91D materials; and b) Vilella reagent, 0.6 g picric acid + 10 mL ethanol + 90 mL H₂O for 10 s, to reveal the grain boundaries of the AZ31 alloy. The tested specimens were examined by scanning electron microscopy (SEM) using a JEOL JSM-6400 microscope equipped with Oxford Link energy-dispersive X-ray (EDX) microanalysis hardware.

2.3. Surface Analysis

Photoelectron spectra were acquired with a Fisons MT500 spectrometer equipped with a hemispherical electron analyser (CLAM 2) and a non-monochromatic magnesium Kα X-ray source operated at 300 W. The specimens were mechanically fixed on small flat discs supported on an XYZ manipulator placed in the analysis chamber. The residual pressure in this ion-pumped analysis chamber was maintained below 10⁻⁸ Torr during data acquisition. Spectra were collected for 20-90 min, depending on the peak intensities, at a pass energy of 20 eV, which is typical of high-resolution conditions. The intensities were estimated by calculating the area under each peak after smoothing and subtraction of the S-shaped background and fitting the experimental curve to a mix of Lorentzian and Gaussian lines of variable proportion. Although specimen charging was observed, it was possible to determine accurate binding energies (BE) by referencing to the adventitious C1s peak at 285.0 eV. Atomic ratios were computed from peak intensity ratios and reported atomic sensitivity factors [48]. The sampled areas were 1 x 1 mm². The energy resolution is about 0.8 eV.

Bombardment was performed using an EXO5 ion gun, incorporated in the equipment, provided with a scanning unit to track the beam and operating at a voltage of 5 kV, an intensity of 10 mA, and a pressure of 1x10⁻⁷ Torr. The sample current was 1 μA during bombardment.

In contrast with the preparation for the metallographic characterisation, XPS results for the pure Mg and Al-Mg alloys are the average of the data obtained in duplicate after only cleaning the as-received specimens with distilled water.

2.4. EIS Measurements

Electrochemical impedance measurements were conducted in 3.5 wt.% NaCl for different times up to 28 days at room temperature (25°C) and pH 5.6, although the pH evolved freely during the experiment. Measurements have been carried out just after the first hour and the first day of immersion, and then weekly. An AUTOLAB potentiostat, model PGSTAT30, with frequency response analyser (FRA) software was used. The frequency ranged from 100 kHz to 1 mHz with 5 points/decade, whereas the amplitude of the sinusoidal potential signal was 10 mV with respect to the open circuit potential (OCP). A three-electrode set-up was

| Table 1. Chemical Composition of Pure Mg and Mg-Al Alloys |
|----------------|----------------|----------------|----------------|----------------|----------------|----------------|----------------|
|                | Al  | Zn  | Mn  | Si  | Cu  | Fe  | Ni  | Ca  | Zr | Others |
| Mg (99%)       | 0.006 | 0.014 | 0.03 | 0.019 | 0.001 | 0.004 | <0.001 | 0.0026 |
| AZ31           | 3.1 | 0.73 | 0.25 | 0.02 | <0.001 | 0.005 | <0.001 | 0.0014 | <0.001 | <0.30 |
| AZ80           | 8.2 | 0.46 | 0.13 | 0.01 | <0.001 | 0.004 | <0.001 | <0.30 |
| AZ91D          | 8.8 | 0.68 | 0.30 | 0.01 | <0.001 | 0.004 | <0.008 | 0.0014 | <0.30 |
employed: Ag/AgCl and graphite were used as reference and counter electrodes, respectively, and the material under study was the working electrode with an immersed area of 2 cm². The electrochemical cell used in the tests contained about 400 ml of solution.

3. RESULTS AND DISCUSSION

3.1. Effect of Microstructural Constituents of Magnesium and Mg-Al Alloys on Native Oxide Film Thickness

3.1.1. Microstructural Characterisation

Fig. (1) shows the SEM microstructure of the tested materials. The pure Mg presented equiaxial grains with an average size of 45 μm, whereas the grain size in the AZ31 alloy was in the 5-100 μm range. The AZ80 and AZ91D casting alloys revealed two different types of microstructures as a function of the solidification rate. For the AZ80 alloy the solidification process, by solid state transformation, promoted a biphasic or cellular microstructure with an α-Mg solid solution (grain size of 100 μm) and a discontinuous precipitation of a fine lamellar aggregate, α-Mg + β-Mg₁₇Al₁₂, (grain size in the 100-200 μm range) (Fig. 1c). With regard to the AZ91D alloy, lower solidification rates promoted α-Mg primary dendrites (40-100 μm) and a partially divorced eutectic α-Mg/Mg₁₇Al₁₂ (coarse particles of 5-60 μm) in the interdendritic region (Fig. 1d). The cast microstructures for each alloy were homogeneous in all the billets [22,23].

3.1.2. XPS Analysis of the Spontaneously Formed Native Oxide Film on Magnesium and Mg-Al Alloys

Table 2, obtained by XPS of the pure magnesium and Mg-Al alloy specimens, shows the absence of aluminium on the outer surface of the spontaneously formed native oxide film on all three studied alloys and suggests a strong tendency for the formation of highly hydrated magnesium hydroxide as it has been observed by Mathieu et al. [19]. This effect is limited to a very superficial portion of the native oxide film, since the removal of about 2 nm (by 10 min of sputtering) has been sufficient to detect the presence of aluminium. It is clear that 10 to 40 min of AIB does not significantly change the Al/(Mg+Al) profile through the bulk material (Table 2). The Al surface enrichment shown in Table 2 is of the same order as that reported elsewhere [13,19,42,49] for Mg-Al alloys with Al contents of ~2-10 wt.% and suggests a moderate tendency for aluminium segregation, whose concentration can increase by a factor of

Fig. (1). SEM micrographs of: (a) unalloyed Mg; (b) AZ31 alloy; (c) AZ80 alloy and (d) AZ91D alloy.
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2-3 at most. The Al/(Mg+Al) ratios obtained by XPS are not proportional to the Al alloying element content (Table 1), and instead seem to indicate a saturation of the specimen's outer surface with aluminium, around 15 wt.% according to Table 2.

Due to strong overlap between the second bulk plasmon of the metallic Mg2p peak and the Al2p peak observed in our measurements, we have measured the Al2s peak instead of the Al2p peak [50]. The evolution of the Al2s high resolution XPS spectrum obtained on the native oxide film formed spontaneously on magnesium and Mg-Al alloys with AIB time is shown in Fig. (2a-l). The obtained spectra are quite similar and contain two components of similar intensities. One appears at a binding energy of 120.5 eV and is associated with the presence of aluminium in oxide form, while the other appears at approximately 118.5 eV and may be attributed to the presence of aluminium in metallic state (Fig. 2d).

Figs. (3a-d) compare the C1s and O1s high resolution XPS spectra obtained on the native oxide film formed spontaneously on magnesium (original surface) and after 10 minutes of sputtering. These spectra are representative of the C1s and O1s spectra observed on the AZ31, AZ80 and AZ91D specimens. The C1s spectrum recorded on the outer surface (Fig. 3a) may be fitted to three components with different intensities. The first and most intense is situated at 285.0 eV and may be attributed to the presence of C-C/C-H groups. At room temperature the surface of any metal, irrespective of its composition, in contact with the atmosphere instantaneously becomes coated with a thin film of C-C/C-H groups (less than 3 nm thickness). A second less intense component appears at 286.5 eV, which may be associated with the presence of C-O groups, and at higher binding energies, 289.0 eV, a third component appears which may be associated with the presence of CO32- [51]. After 10 minutes of AIB (Fig. 2b) the component associated with the presence of carbonate disappears and this third component shifts 1 eV towards lower binding energies and may be associated with the presence of O-C=O groups below the outer carbonate layer. This suggests that the carbonate layer is limited to the outermost surface.

The O1s spectrum (Fig. 3c) shows the most intense component at 532.2 eV. This component may be associated principally with the presence of oxygen in the form of magnesium hydroxide (Mg(OH)2) [51]. Two less intense components appear at binding energies of 530.2 eV and

| Table 2. Atomic Percentage Observed by XPS on the Outer Surface of the Native Oxide Film Formed on Pure Mg and Mg-Al Alloys After AIB |
|----------------------------------|----------|----------|----------|----------|----------------|--------------------|
|                                   | % O      | % Mg     | % Al     | % Ca     | Al/(Al+Mg)    | Ca/(Ca+Mg)        |
| Mg PURE                          |          |          |          |          |                |                   |
| 0                                | 82       | 13       | 0        | 5        | 0              | 0.28               |
| +10 MIN AIB                      | 64       | 32       | 0        | 3        | 0              | 0.09               |
| +20 MIN AIB                      |          |          |          |          |                |                   |
| +30 MIN AIB                      |          |          |          |          |                |                   |
| +40 MIN AIB                      |          |          |          |          |                |                   |
| AZ31                             |          |          |          |          |                |                   |
| 0                                | 80       | 16       | 0        | 2        | 0              | 0.11               |
| +10 MIN AIB                      | 68       | 25       | 4        | 2        | 0.14           | 0.07               |
| +20 MIN AIB                      | 69       | 27       | 4        | 0        | 0.13           | 0                  |
| +30 MIN AIB                      | 69       | 27       | 4        | 0        | 0.13           | 0                  |
| +40 MIN AIB                      | 66       | 29       | 5        | 0        | 0.14           | 0                  |
| AZ80                             |          |          |          |          |                |                   |
| 0                                | 83       | 15       | 0        | 2        | 0              | 0.12               |
| +10 MIN AIB                      | 60       | 31       | 5        | 2        | 0.12           | 0.06               |
| +20 MIN AIB                      | 55       | 39       | 5        | 0        | 0.11           | 0.00               |
| +30 MIN AIB                      | 54       | 40       | 5        | 0        | 0.11           | 0.00               |
| +40 MIN AIB                      | 51       | 42       | 6        | 0        | 0.12           | 0.00               |
| AZ91D                            |          |          |          |          |                |                   |
| 0                                | 73       | 25       | 0        | 2        | 0              | 0.07               |
| +10 MIN AIB                      | 55       | 40       | 5        | 0        | 0.11           | 0.00               |
| +20 MIN AIB                      | 52       | 42       | 6        | 0        | 0.12           | 0.00               |
| +30 MIN AIB                      | 47       | 45       | 8        | 0        | 0.15           | 0.00               |
| +40 MIN AIB                      | 46       | 46       | 8        | 0        | 0.15           | 0.00               |
534.2 eV which may be associated with the presence of oxygen in the form of calcium oxide [52] and water or C-O groups. After 10 minutes (Fig. 3d) the second component is seen to shift 1 eV towards lower binding energies and may be associated with the presence of MgO below the outer Mg(OH)₂ layer.

The evolution of the Mg2p high resolution XPS spectrum obtained on the native oxide film formed spontaneously on
magnesium and Mg-Al alloys with AIB time is shown in Fig. (4a-n). The spectra obtained on the original surface (Fig. 4a-d) are fairly similar, containing one single component at a binding energy of 50.8 eV associated with the presence of magnesium in the form of magnesium hydroxide [51]. Fig. (4e-h) show the spectra obtained after 10 minutes of AIB. The spectra observed on the magnesium (Fig. 4e) and AZ31 (Fig. 4f) show the most intense component at a binding energy of 48.6 eV associated with the presence of magnesium in metallic state and another less intense component at a binding energy of 50.8 eV which may be associated with the presence of magnesium in the form of magnesium oxide (demonstrated by the O1s peak (Fig. 3d)). It is interesting to draw attention to the considerably lower intensity of the metallic magnesium signal on AZ80 (Fig. 4g) and AZ91D (Fig. 4h) than on Mg (Fig. 4e) and AZ31 (Fig. 4f). This result is interpreted as being due to the greater thickness of the native oxide film in the first two cases.

The thickness of the native oxide film on the surface of the magnesium specimens was calculated using the expression given by Strohmeier [53]:

$$d_o (\text{nm}) = \frac{\lambda_{\text{oxide}} \sin \theta \ln (I_{\text{oxide}} \times N_m)/(I_{\text{metal}} \times N_{\text{oxide}})}{\lambda_{\text{metal}} \times N_m + 1}$$

where $d_o$ is the thickness of the magnesium oxide layer (in nm); $\theta$ is the photoelectron output angle; $I_{\text{metal}}$ and $I_{\text{oxide}}$ are the intensities of the magnesium components in the metallic state and as oxide from the Mg 2p peak (Fig. 4a-n); $\lambda_{\text{metal}}$ and $\lambda_{\text{oxide}}$ are the mean free paths of photoelectrons in the substrate and the oxide layer; and $N_m$ and $N_o$ are the volume densities of magnesium atoms in metal and oxide [54]. The values of $\lambda_{\text{metal}}$ and $\lambda_{\text{oxide}}$ are 3.0 [55] and 2.6 nm [56], respectively [57], and an $N_m/N_o$ ratio of 1.0 was used [58]. On the pure Mg and AZ31 alloy an important increase was seen in the intensity of the Mg signal after 10 minutes of AIB (Fig. 4e, f). However, the fact that the intensity of the component associated with metallic magnesium ($I_{\text{metal}}$) is practically negligible on AZ80 and AZ91D after 10 minutes of AIB (Fig. 4g, h) implies a problem for the thickness determination of the surface oxide layers. The sputtering rate can be estimated by the above equation when metallic Mg emerged after a certain sputtering time [51]. The sputtering rate of the native oxide films for Mg and Mg alloys is about 0.15 nm/min. This value is close to the sputtering rates obtained by Yao et al. [51] for Mg in air and previous results from the authors on interstitial-free (IF) steels [59]. Table 3 shows the oxide layer thickness values obtained by multiplying the AIB time necessary for a significant metallic magnesium component to appear in the Mg2p peak (Fig. 4e, f, i, j) at the sputtering rate (0.15 nm/min). The values obtained are similar to those reported in the literature [43, 44, 60]. It is interesting to note that the thickness of the

![Fig. (4). Evolution with AIB time of the Mg 2p high-resolution XPS spectra for pure Mg, AZ31, AZ80 and AZ91 specimens.](image)
native oxide film formed spontaneously on AZ80 and AZ91D alloys (obtained after 20 minutes of AIB) is approximately twice that observed on the magnesium and AZ31 specimens (obtained after 10 minutes of AIB) (Table 3). These results show some similarity to those observed by Splinter and McIntyre [46] who found that the rate of oxide nucleation and growth is enhanced on Mg-Al surfaces compared to pure Mg surfaces, especially at higher Al contents. Furthermore, the thickness of the native oxide film on the AZ80 alloy is greater than that observed on the AZ91D alloy (Table 3).

Table 3. Native Oxide Film Thickness (nm), Transfer Resistance ($R_t$) and Corrosion Rate (mg/cm²/Day)

<table>
<thead>
<tr>
<th>Material</th>
<th>Film Thickness (nm)</th>
<th>$R_t$ ($\Omega$ cm²)</th>
<th>Corrosion Rate (mg/cm²/Day)</th>
</tr>
</thead>
<tbody>
<tr>
<td>Pure Mg</td>
<td>2.6</td>
<td>~10</td>
<td>~50</td>
</tr>
<tr>
<td>AZ31</td>
<td>2.8</td>
<td>162</td>
<td>3.4</td>
</tr>
<tr>
<td>AZ91D</td>
<td>4.4</td>
<td>491</td>
<td>1.1</td>
</tr>
<tr>
<td>AZ80</td>
<td>6.3</td>
<td>2900</td>
<td>0.2</td>
</tr>
</tbody>
</table>

3.1.3. Effect of Surface Heterogeneities on Native Oxide Film Thickness

Thickness differences (of nm order) in the native oxide layer formed spontaneously on metallic materials have been related with the presence of imperfections or heterogeneities where the film is more pervious to the movement of the reaction products [44, 61, 62]. In the commercial magnesium alloys tested in this work there also seems to be a direct relation between the native oxide film thickness and the degree of microstructural complexity of the surface upon which it forms. Thus, Fig. (1) shows a very significant presence of $\beta$ intermetallic phase on the surfaces of AZ80 (Fig. 1c) and AZ91D (Fig. 1d) compared to its absence on AZ31 (Fig. 1b) and pure Mg (Fig. 1a). Chill casting process promoted a biphasic microstructure in the AZ80 alloy, with $\alpha$-Mg solid solution and discontinuous precipitation in lamellar form of $\beta$-phase ($\text{Mg}_{17}\text{Al}_{12}$) (Fig. 1c). On the other hand, slower cooling casting produced a coarse eutectic dendritic microstructure in the AZ91D alloy and a lower percentage of magnesium surface covered by intermetallic phases (Fig. 1d) [23].

3.1.4. Effect of Native Oxide Film Thickness on Corrosion Resistance of Commercial Magnesium Alloys Exposed to a 3.5% NaCl Solution

Fig. (5) compares the Nyquist diagrams obtained with (a) AZ31, (b) AZ80 and (c) AZ91D alloy specimens exposed to a 3.5% NaCl solution for 1 and 28 days. These diagrams are representative of the plots observed for the AZ31, AZ80 and AZ91D specimens after other testing times. They present one single arc with an inductive tail at the lowest frequencies. The charge transfer resistance values, $R_t$, deduced from the HF-MF arc of the Nyquist plots after 1 day of testing for the materials immersed in 3.5% NaCl [23] are shown in column 2 of Table 3. Fig. (7), which is lacking information for pure Mg because this specimen dissolved.
after just a few days of testing) shows that $R_t$ values for the Mg alloys have changed little over the 28 days of exposure. The exceptionally high corrosion rate of the pure Mg specimen has yielded very irregular impedance measurements, so the information for this material in Table 3 should be viewed as a typical trend rather than a precise datum.

![Fig. (6). Evolution of $R_t$ values with exposure time to NaCl 3.5 wt % on commercial magnesium alloys.](image)

In general, Table 3 shows a clear trend towards an increase in $R_t$ values and, therefore, a decrease in corrosion rate values as the thickness of the spontaneously formed MgO film increases. This correspondence between electrochemical value and the native oxide film thickness suggests that the native oxide film formed spontaneously in contact with the atmosphere somehow controls the corrosive attack. However, the doubt arises as to how an oxide film of just a few nanometres in thickness can have a prolonged influence on the corrosion process in saline solution, with much a greater metal dissolution than the thickness of the film. An explanation may be that the film, that is damaged by dissolution, is rapidly repaired or replaced in the aqueous medium by a film of essentially similar characteristics. According to a Cabrera-Mott type mechanism [63], such behaviour may be expected of a film that is sufficiently thin for the electrons to pass through it by a tunnel effect and to react with oxygen or water adsorbed on the outer surface, while at the same times cations enter the film at the metal/film interface. Work by Nordlien et al. [13, 14, 45] suggests that the original air-formed film is a highly stable form of oxide that preserves its properties when the specimen is exposed to the aqueous environment. The immersed metal could corrode by undermining this oxide film, which is detached from the metallic surface and subsists throughout the corrosion test as a membrane sandwiched between two much thicker porous layers of corrosion products [13, 14, 45]. However, it is difficult to imagine that this membrane, separated from the metallic surface by about 100-200 nm of corrosion products, can control corrosion rate and thus be directly responsible for the measured $R_t$ values. It seems more probable that the original air-formed film, when separated from the metallic surface, is rapidly replaced by a new film formed by direct contact between the metal and the aqueous medium, in a constant process of breakdown and repair. It should also be supposed that the thickness of this film is similar to that of the air-formed film, perhaps because the parameters which determine its growth are much more dependent on the characteristics of the tested material (e.g. the amount of metal atoms located at favourable positions, that can jump over the energy barrier into the oxide) than on the medium to which it is exposed.

Imperfections in the solid film formed on the metal surface, in particular pores extending as microchannels from the metal surface to the solution interface, could determine the corrosion rate of the metallic substrate. In this case, the measured $R_t$ values per apparent area unit refer to the fraction of the metal exposed to the aqueous solution at the base of these channels. The relation between the values of $R_t$ and native oxide film thickness shown in Fig. (7) for the three tested alloys requires further consideration. This relation could be explained, for instance, by considering that the probability of a channel of interconnected pores passing through the entire thickness of a film is an exponential function of the inverse of the thickness [64].

### 3.2. Characterisation of calcium impurity segregation on the magnesium surface

#### 3.2.1. XPS Analysis of the Surface of Pure Mg and Mg-Al Alloys

Table 2 shows the element compositions obtained by XPS on the native oxide film formed on pure Mg and Mg-Al alloys. Attention is drawn to the presence of significant amounts of Ca on all the studied alloys. The Ca/(Ca+Mg) atomic ratios obtained by XPS on magnesium metal reach values close to 0.28, which could suggest that calcium covers approximately 28% of the magnesium surface. It is also important to note the absence of significant amounts, within the detection limits of our XPS spectrometer, of other alloying elements such as Zn, Mn and Si on the surface of the studied alloys.

As to the origin of superficial calcium enrichment, one possibility is that Ca species may have been incorporated in the hydroxide/oxide film that coats the surface during the cleaning process. However, the fact that XPS analysis of the
The outermost surface of pure Mg (Table 2) shows approximately twice the calcium content of the AZ31, AZ80 and AZ91D alloys exposed to the same cleaning procedure suggests that this is not the origin of the phenomenon. In fact, this proportion is practically identical to that of the calcium content in the bulk of these materials (Table 1), so it seems likely that the observed superficial calcium enrichment is due to the calcium contained as an impurity in the bulk alloy.

Fig. (8) shows the evolution of the Ca2p high resolution XPS spectra observed on the magnesium surface with AIB time. These spectra are representative of the Ca2p spectra observed on the surfaces of the other materials. The Ca2p high resolution spectrum contains one single doublet with a binding energy of 347.0 eV (Fig. 5a), which is typical of Ca as Ca2+ [52]. Thus the significant Ca content observed by XPS on the surface of the material would be found as CaO. The literature mentions a tendency for external CaO layers to form during the annealing process of MgO(100) crystals containing calcium as an impurity [65-67]. Such enrichment is favoured because the relative Gibbs free energy per equivalent (ΔG/n) for the formation of calcium oxide is more positive than that for MgO. The effect is similar to that observed in magnesium alloys with calcium additions as an alloying element [52,68-70].

It is interesting to note that the Ca content observed in the XPS analysis of the outer surface of the Mg specimens tends to decline quickly with AIB time (Table 2 and Fig. 8), probably because the presence of a significant calcium content in oxide form in the magnesium specimens is limited to the outermost surface. This result is similar to that obtained by R. Souda et al. [66] who, working with MgO crystals including 210 ppm bulk Ca impurities, found that Ca ions exist only in the outermost layer and that Ca enrichment does not take place in the deepest layers.
3.2.2. EIS Measurements of Effect of Calcium

It was of interest to study the possible effect of calcium segregation on the protective properties of the native oxide layer formed spontaneously on the pure Mg specimens. With this intention charge transfer resistance values were obtained after just 1 hour of testing for the materials immersed in a 0.005 M NaCl solution [71]. The short testing time and the only mildly aggressive solution were selected in view of the exceptionally high corrosion rates of the Mg specimens. Gentle polishing of the pure Mg and the AZ31 alloy surfaces was performed with the aim of eliminating the Ca surface segregation (removed thickness was equivalent to 10 μm). Fig. (9) compares the Nyquist diagrams obtained with the original magnesium and AZ31 alloy specimens without and after gentle polishing. Taking the original surface as the reference (Fig. 9a), polishing tends to decrease the size of the high and medium frequency arc in the Nyquist diagram (Fig. 9b), and thus the charge transfer resistance value (Rt) associated with this arc; the reduction has been around 3 times with pure Mg and 1.5 times with the AZ31 alloy. Bearing in mind that the thickness of the native oxide film coating on the pure magnesium surface is very thin (Table 3) and the absence of aluminium oxides, it may be speculated that the presence of a CaO layer on the magnesium surface has raised the Rt values. These results show a certain similarity with those observed by Jihua et al. [72], indicating that the trace Ca addition was beneficial to the corrosion resistance improvement of magnesium alloys.

CONCLUSIONS

1. Notable differences have been seen in the thickness of the native oxide film observed by XPS on the surface of the different studied magnesium-based materials. The greatest thicknesses correspond to the AZ80 and AZ91D alloys, and the smallest to the pure Mg and the AZ31 alloy. These thickness variations suggest the influence of film imperfections and the degree of microstructural heterogeneity of the studied materials on this parameter.

2. An inverse type relationship was seen between the thickness of the native oxide film formed spontaneously on the surface of the Mg-Al alloys and the corrosion rate of the specimens during the subsequent immersion test. This behaviour seems to suggests a great influence of the thin films formed by electron tunnelling on the corrosion rate.

3. On the pure Mg and the studied Mg-Al alloys a strong tendency was seen for the calcium impurity to segregate, mainly as CaO, to the outermost surface of the specimens; the atomic fraction of Ca segregated being almost 1500 times the atomic fraction in the bulk.

4. On all three studied Mg-Al alloys, moderate segregation of the Al alloying element towards a surface region immediately below the outermost surface layer of the native oxide film has been observed. The segregated aluminium content is very similar in all three studied alloys and independent of the aluminium concentration in the bulk alloy, which seems to suggest a saturation of the metallic surface in this element.

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